

N-Channel 30-V (D-S) MOSFET

Description

The device is the highest performance trench N-ch MOSFETs with extreme high cell density, which provide excellent $R_{DS(ON)}$ and gate charge for most of the synchronous buck converter applications. The device meets the RoHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.

Features

- R_{DS(ON)} =9mΩ@ V_{GS} =10V
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% EAS Guaranteed
- Green Device Available

Typical Applications

- MB / VGA / Vcore
- POL Applications
- SMPS 2nd SR

Package type : PDFN 3.3X3.3

Packing & Order Information

3,000/Reel



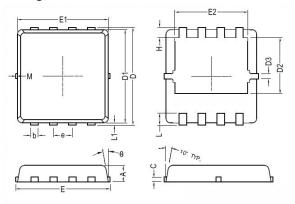




S

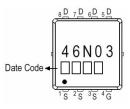
Graphic Symbol

Package Dimension



REF.	Millimeter		REF.	Millimeter				
	Min.	Nom.	Max.		Min.	Nom.	Max.	
Α	0.70	0.75	0.80	E1	3.00	3.15	3.20	
b	0.25	0.30	0.35	E2	2.39	2.59		
С	0.10	0.15	0.25	е	0.65 BSC			
D	3.25	3.35	3.45	Н	0.30	0.50		
D1	3.00	3.10	3.20	L	0.30	0.40	0.50	
D2	1.78	1.88	1.98	L1	- 0.13		0.20	
D3	-	0.13	-	θ	- 10°		12°	
E	3.20	3.30	3.40	М	-	-	0.15	

Marking



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MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings					
Symbol	Parameter	Value	Units		
VDS	Drain-Source Voltage	30	V		
V _{GS}	Gate-Source Voltage	±20	V		
1-	Continuous Drain Current ¹ (T _c =25°C)	464	А		
ID	Continuous Drain Current ¹ (Tc=100°C)	29	А		
IDM	Pulsed Drain Current ^{1,2}	92	А		
las	Single Pulse Avalanche Current, L =0.1mH ³	34	А		
Eas	Single Pulse Avalanche Energy, L =0.1mH ³	57.8	mJ		
D	Power Dissipation ⁴ (T _c =25°C)	29	W		
PD	Power Dissipation ⁴ (T _A =25°C)	1.67	W		
TJ/Tstg	Operating Junction and Storage Temperature	-55 to +150	°C		

Thermal Resistance Ratings					
Symbol	Parameter	Maximum	Units		
$R_{\theta JA}$	Maximum Junction-to-Ambient ¹	75	°C/W		
Rejc	Maximum Junction-to-Case ¹	4.3	°C/W		

Electrical Characteristics (T」=25°C unless otherwise specified)						
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
V _{GS (th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	1.0	-	2.5	V
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250µA	30	-	-	V
g fs	Forward Transconductance	V _{DS} =5V, I _D =15A	-	9.8	-	S
Igss	Gate-Source Leakage Current	V _{DS} =0V, V _{GS} =±20V	-	-	±100	nA
IDSS	Drain-Source Leakage Current	V_{DS} =24V, V_{GS} =0V, T_J =25°C		-	1	μA
		V_{DS} =24V, V_{GS} =0V, T_{J} =55°C	-		5	
R _{DS (on)}	Static Drain-Source On-Resistance ²	V _{GS} =10V, I _D =15A	-	-	9	mΩ
		V _{GS} =4.5V, I _D =10A	-	-	15	
EAS	Single Pulse Avalanche Energy ⁵	V _{DD} =25V, L =0.1mH, I _{AS} =20A	20		-	mJ
Vsd	Diode Forward Voltage ²	Is =15A, V _{GS} =0V, T _J =25°C	-	-	1.2	V
ls	Continuous Source Current ^{1,6}		-	-	40	
lsм	Pulsed Source Current ^{2,6}	$V_{G} = V_{D} = 0V$, Force Current	-	-	80	A



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Dynamic						
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Qg	Total Gate Charge ²	V _{DS} =20V		12.8		
Qgs	Gate-Source Charge	I _D =12A		3.3		nC
Qgd	Gate-Drain Charge	V _{GS} =4.5V		6.5		
td(on)	Turn-On Delay Time ²	V _{DS} =12V		4.5		
tr	Rise Time	I _D =5A		10.8		
td(off)	Turn-Off Delay Time	V _{GS} =10V		25.5		ns
tf	Fall Time	$R_G = 3.3\Omega$		9.6		-
Ciss	Input Capacitance	V _{DS} =15V		1317		
Coss	Output Capacitance	V _{GS} =0V		163		pF
CRSS	Reverse Transfer Capacitance	f =1.0MHz		131		1
Rg	Gate Resistance	V _{GS} =V _{DS} =0V, f =1.0MHz		1.7		Ω

Notes

1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.

2. The data tested by pulsed, pulse width \leq 300us, duty cycle \leq 2%.

3. The EAS data shows maximum rating. The test condition is V_{DD} =25V, V_{GS} =10V, L=0.1mH, I_{AS}=34A.

4. The power dissipation is limited by 150° C junction temperature. Package Limitation current is 40A.

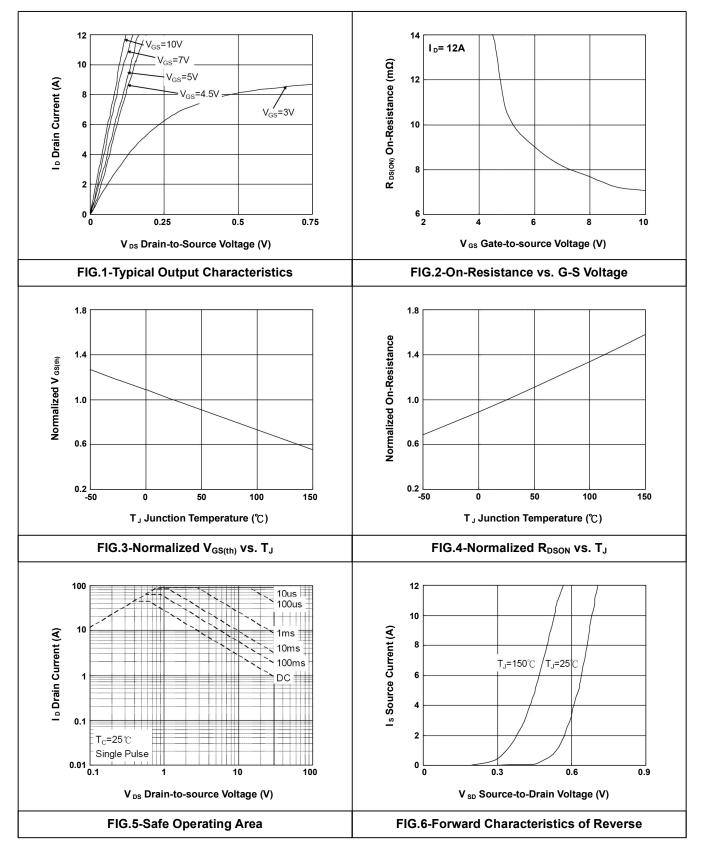
5. The Min. value is 100% EAS tested guarantee.

6. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



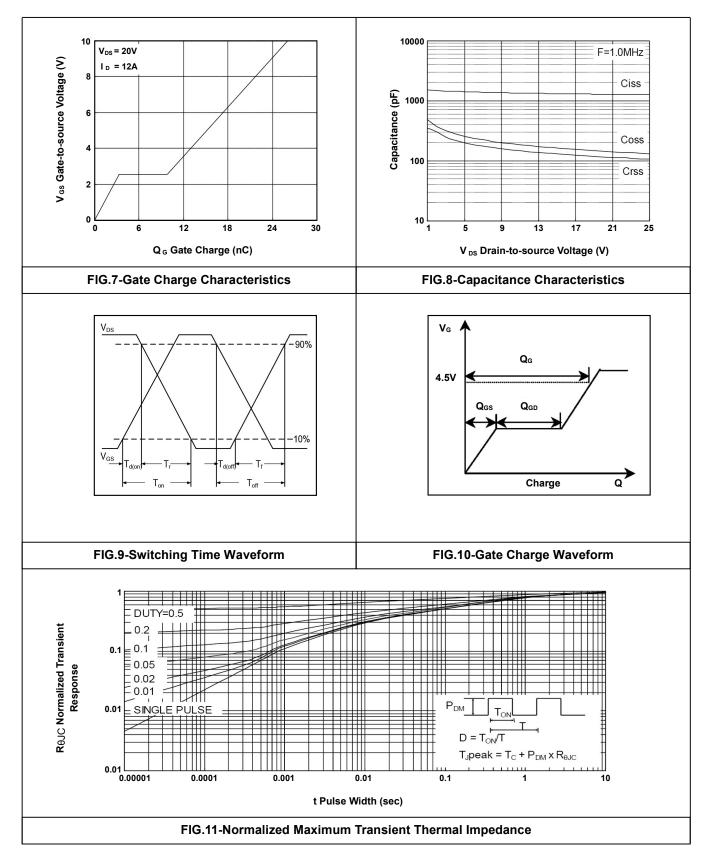
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• Typical Electrical Characteristics





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